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Title:Broadband terahertz pulse emission from ZnGeP<sub>2</sub>

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Abstract:Optical rectification is demonstrated in(110)-cut ZnGeP<sub>2</sub> (ZGP) providing broadband terahertz (THz) generation. The source is compared to both GaP and GaAs over a wavelength range of 1150 nm to 1600 nm and peak-intensity range of 0.5 GW/cm<sup>2</sup> to 40 GW/cm<sup>2</sup>. ZGP peak-to-peak field amplitude is larger than in the other materials due to either lower nonlinear absorption or larger second-order nonlinearity. This material is well suited for broadband THz generation across a wide range of infrared excitation wavelengths. &copy; 2012 Optical Society of America.

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